Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination	
10509753	YAMAWAKI ET AL.	
Examiner	Art Unit	
Chen, Junpeng	2631	

SEARCHED					
Class	Subclass	Date	Examiner		
455	39,126, 295, 522	02/03/2007	J.C.		
331	135				
375	332, 376,297,345,				
330	129,51,285				

SEARCH NOTES				
Search Notes	Date	Examiner		
EAST Image and keyword search in USPAT, US-PGPub, DERWENT, EPO, JPO and IBM_TDB	05/04/2006	J.C.		
Consulted with Nguyen Vo and Quochien Vuong	05/09/2006	J.C.		
Googled "second order lag lead filter"	02/03/2007	J.C.		

INTERFERENCE SEARCH					
Class	Subclass	Date	Examiner		
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